

## MOSFET

### 650 V CoolSiC™ M1 SiC Trench Power Device

The 650 V CoolSiC™ is built over the solid silicon carbide technology developed in Infineon in more than 20 years. Leveraging the wide bandgap SiC material characteristics, the 650V CoolSiC™ MOSFET offers a unique combination of performance, reliability and ease of use. Suitable for high temperature and harsh operations, it enables the simplified and cost effective deployment of the highest system efficiency.

#### Features

- Optimized switching behavior at higher currents
- Commutation robust fast body diode with low  $Q_{rr}$
- Superior gate oxide reliability
- Best thermal conductivity and behavior
- Lower  $R_{DS(on)}$  and pulse current dependency on temperature
- Increased avalanche capability
- Compatible with standard drivers (recommended driving voltage: 18V)
- Kelvin source provides up to 4 times lower switching losses

#### Benefits

- Unique combination of high performance, high reliability and ease of use
- Ease of use and integration
- Suitable for topologies with continuous hard commutation
- Higher robustness and system reliability
- Efficiency improvement
- Reduced system size leading to higher power density

#### Potential applications

- SMPS
- UPS (uninterruptable power supplies)
- Solar PV inverters
- EV charging infrastructure
- Energy storage and battery formation
- Class D amplifiers

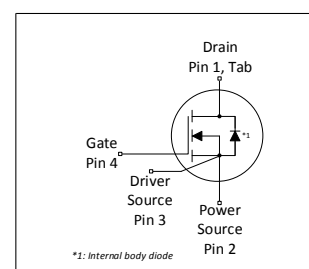
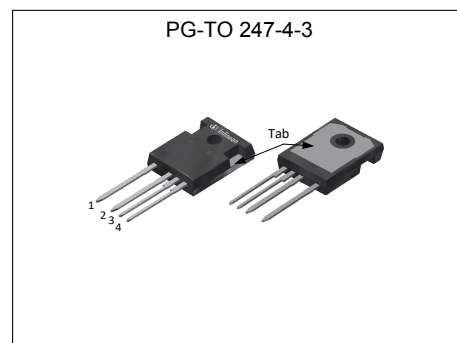
#### Product validation

Fully qualified according to JEDEC for Industrial Applications

**Table 1 Key Performance Parameters**

| Parameter                     | Value | Unit |
|-------------------------------|-------|------|
| $V_{DS} @ T_J = 25\text{ °C}$ | 650   | V    |
| $R_{DS(on),typ}$              | 27    | mΩ   |
| $Q_{G,typ}$                   | 63    | nC   |
| $I_{D,pulse}$                 | 184   | A    |
| $Q_{oss} @ 400\text{ V}$      | 147   | nC   |
| $E_{oss} @ 400\text{ V}$      | 22.2  | μJ   |

| Type / Ordering Code | Package       | Marking  | Related Links  |
|----------------------|---------------|----------|----------------|
| IMZA65R027M1H        | PG-TO 247-4-3 | 65R027M1 | see Appendix A |



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## 1 Maximum ratings

at  $T_J = 25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                                         | Symbol        | Values |      |          | Unit | Note / Test Condition                                                               |
|---------------------------------------------------|---------------|--------|------|----------|------|-------------------------------------------------------------------------------------|
|                                                   |               | Min.   | Typ. | Max.     |      |                                                                                     |
| Continuous drain current <sup>1)</sup>            | $I_D$         | -      | -    | 59<br>41 | A    | $T_C = 25\text{ °C}$<br>$T_C = 100\text{ °C}$                                       |
| Pulsed drain current <sup>2)</sup>                | $I_{D,pulse}$ | -      | -    | 184      | A    | $T_C = 25\text{ °C}$                                                                |
| Avalanche energy, single pulse                    | $E_{AS}$      | -      | -    | 326      | mJ   | $I_D = 12.2\text{ A}$ , $V_{DD} = 50\text{ V}$ , $L = 4.4\text{ mH}$ ; see table 10 |
| Avalanche energy, repetitive                      | $E_{AR}$      | -      | -    | 1.63     | mJ   | $I_D = 12.2\text{ A}$ , $V_{DD} = 50\text{ V}$ ; see table 10                       |
| Avalanche current, single pulse                   | $I_{AS}$      | -      | -    | 12.2     | A    | -                                                                                   |
| MOSFET $dv/dt$ ruggedness                         | $dv/dt$       | -      | -    | 200      | V/ns | $V_{DS} = 0...400\text{ V}$                                                         |
| Gate source voltage (recommended driving voltage) | $V_{GS}$      | 0      | -    | 18       | V    | AC ( $f > 1\text{ Hz}$ )                                                            |
| Gate source voltage (dynamic)                     | $V_{GS}$      | -5     | -    | 23       | V    | $t_{pulse,negative} \leq 15\text{ ns}$                                              |
| Power dissipation                                 | $P_{tot}$     | -      | -    | 189      | W    | $T_C = 25\text{ °C}$                                                                |
| Storage temperature                               | $T_{stg}$     | -55    | -    | 150      | °C   | -                                                                                   |
| Operating junction temperature                    | $T_J$         | -55    | -    | 150      | °C   | -                                                                                   |
| Mounting torque                                   | -             | -      | -    | 60       | Ncm  | M3 and M3.5 screws                                                                  |
| Continuous diode forward current <sup>1)</sup>    | $I_S$         | -      | -    | 59       | A    | $T_C = 25\text{ °C}$                                                                |
| Diode pulse current <sup>2)</sup>                 | $I_{S,pulse}$ | -      | -    | 184      | A    | $T_C = 25\text{ °C}$                                                                |
| Insulation withstand voltage                      | $V_{ISO}$     | -      | -    | n.a.     | V    | $V_{rms}$ , $T_C = 25\text{ °C}$ , $t = 1\text{ min}$                               |

<sup>1)</sup> Limited by  $T_{J,max}$

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{J,max}$

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                                  | Symbol     | Values |      |      | Unit | Note / Test Condition               |
|------------------------------------------------------------|------------|--------|------|------|------|-------------------------------------|
|                                                            |            | Min.   | Typ. | Max. |      |                                     |
| Thermal resistance, junction - case                        | $R_{thJC}$ | -      | -    | 0.66 | °C/W | -                                   |
| Thermal resistance, junction - ambient                     | $R_{thJA}$ | -      | -    | 62   | °C/W | leaded                              |
| Thermal resistance, junction - ambient for SMD version     | $R_{thJA}$ | -      | -    | -    | °C/W | n.a.                                |
| Soldering temperature, wavesoldering only allowed at leads | $T_{sold}$ | -      | -    | 260  | °C   | 1.6mm (0.063 in.) from case for 10s |

### 3 Electrical characteristics

at  $T_J = 25\text{ °C}$ , unless otherwise specified

**Table 4 Static characteristics**

| Parameter                            | Symbol        | Values |                |            | Unit | Note / Test Condition                                                                                                                             |
|--------------------------------------|---------------|--------|----------------|------------|------|---------------------------------------------------------------------------------------------------------------------------------------------------|
|                                      |               | Min.   | Typ.           | Max.       |      |                                                                                                                                                   |
| Drain-source breakdown voltage       | $V_{(BR)DSS}$ | 650    | -              | -          | V    | $V_{GS} = 0\text{ V}$ , $I_D = 1.1\text{ mA}$                                                                                                     |
| Gate threshold voltage <sup>1)</sup> | $V_{(GS)th}$  | 3.5    | 4.5            | 5.7        | V    | $V_{DS} = V_{GS}$ , $I_D = 11\text{ mA}$                                                                                                          |
| Zero gate voltage drain current      | $I_{DSS}$     | -      | 1<br>2         | 150<br>-   | μA   | $V_{DS} = 650\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 25\text{ °C}$<br>$V_{DS} = 650\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 150\text{ °C}$ |
| Gate-source leakage current          | $I_{GSS}$     | -      | -              | 100        | nA   | $V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$                                                                                                    |
| Drain-source on-state resistance     | $R_{DS(on)}$  | -      | 0.027<br>0.035 | 0.034<br>- | Ω    | $V_{GS} = 18\text{ V}$ , $I_D = 38.3\text{ A}$ , $T_J = 25\text{ °C}$<br>$V_{GS} = 18\text{ V}$ , $I_D = 38.3\text{ A}$ , $T_J = 150\text{ °C}$   |
| Gate resistance                      | $R_G$         | -      | 3.0            | -          | Ω    | $f = 1\text{ MHz}$ , open drain                                                                                                                   |

**Table 5 Dynamic characteristics**

| Parameter                                                  | Symbol       | Values |      |      | Unit | Note / Test Condition                                                                                            |
|------------------------------------------------------------|--------------|--------|------|------|------|------------------------------------------------------------------------------------------------------------------|
|                                                            |              | Min.   | Typ. | Max. |      |                                                                                                                  |
| Input capacitance                                          | $C_{iss}$    | -      | 2131 | -    | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$                                           |
| Reverse capacitance                                        | $C_{riss}$   | -      | 22   | -    | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$                                           |
| Output capacitance <sup>2)</sup>                           | $C_{oss}$    | -      | 244  | 317  | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$                                           |
| Output charge <sup>2)</sup>                                | $Q_{oss}$    | -      | 147  | 191  | nC   | calculation based on $C_{oss}$                                                                                   |
| Effective output capacitance, energy related <sup>3)</sup> | $C_{o(er)}$  | -      | 278  | -    | pF   | $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = 0...400\text{ V}$                                                           |
| Effective output capacitance, time related <sup>4)</sup>   | $C_{o(tr)}$  | -      | 368  | -    | pF   | $I_D = \text{constant}$ , $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = 0...400\text{ V}$                                 |
| Turn-on delay time                                         | $t_{d(on)}$  | -      | 21.4 | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 38.3\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 9 |
| Rise time                                                  | $t_r$        | -      | 4.2  | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 38.3\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 9 |
| Turn-off delay time                                        | $t_{d(off)}$ | -      | 21.6 | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 38.3\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 9 |
| Fall time                                                  | $t_f$        | -      | 8.4  | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 18\text{ V}$ , $I_D = 38.3\text{ A}$ ,<br>$R_G = 1.8\text{ Ω}$ ; see table 9 |

<sup>1)</sup> Tested after 1 ms pulse at  $V_{GS} = +20\text{ V}$

<sup>2)</sup> Maximum specification is defined by calculated six sigma upper confidence bound

<sup>3)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V

<sup>4)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V

**Table 6 Gate charge characteristics**

| Parameter             | Symbol   | Values |      |      | Unit | Note / Test Condition                                                                   |
|-----------------------|----------|--------|------|------|------|-----------------------------------------------------------------------------------------|
|                       |          | Min.   | Typ. | Max. |      |                                                                                         |
| Gate to source charge | $Q_{gs}$ | -      | 17   | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_D = 38.3\text{ A}$ ,<br>$V_{GS} = 0\text{ to }18\text{ V}$ |
| Gate to drain charge  | $Q_{gd}$ | -      | 14   | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_D = 38.3\text{ A}$ ,<br>$V_{GS} = 0\text{ to }18\text{ V}$ |
| Gate charge total     | $Q_g$    | -      | 63   | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_D = 38.3\text{ A}$ ,<br>$V_{GS} = 0\text{ to }18\text{ V}$ |

**Table 7 Reverse diode characteristics**

| Parameter                     | Symbol    | Values |      |      | Unit | Note / Test Condition                                                                                 |
|-------------------------------|-----------|--------|------|------|------|-------------------------------------------------------------------------------------------------------|
|                               |           | Min.   | Typ. | Max. |      |                                                                                                       |
| Diode forward voltage         | $V_{SD}$  | -      | 4.0  | -    | V    | $V_{GS} = 0\text{ V}$ , $I_F = 38.3\text{ A}$ , $T_J = 25\text{ °C}$                                  |
| Reverse recovery time         | $t_{rr}$  | -      | 102  | -    | ns   | $V_R = 400\text{ V}$ , $I_F = 38.3\text{ A}$ ,<br>$di_F/dt = 1000\text{ A}/\mu\text{s}$ ; see table 8 |
| Reverse recovery charge       | $Q_{rr}$  | -      | 239  | -    | nC   | $V_R = 400\text{ V}$ , $I_F = 38.3\text{ A}$ ,<br>$di_F/dt = 1000\text{ A}/\mu\text{s}$ ; see table 8 |
| Peak reverse recovery current | $I_{rrm}$ | -      | 10.6 | -    | A    | $V_R = 400\text{ V}$ , $I_F = 38.3\text{ A}$ ,<br>$di_F/dt = 1000\text{ A}/\mu\text{s}$ ; see table 8 |

## 4 Electrical characteristics diagrams

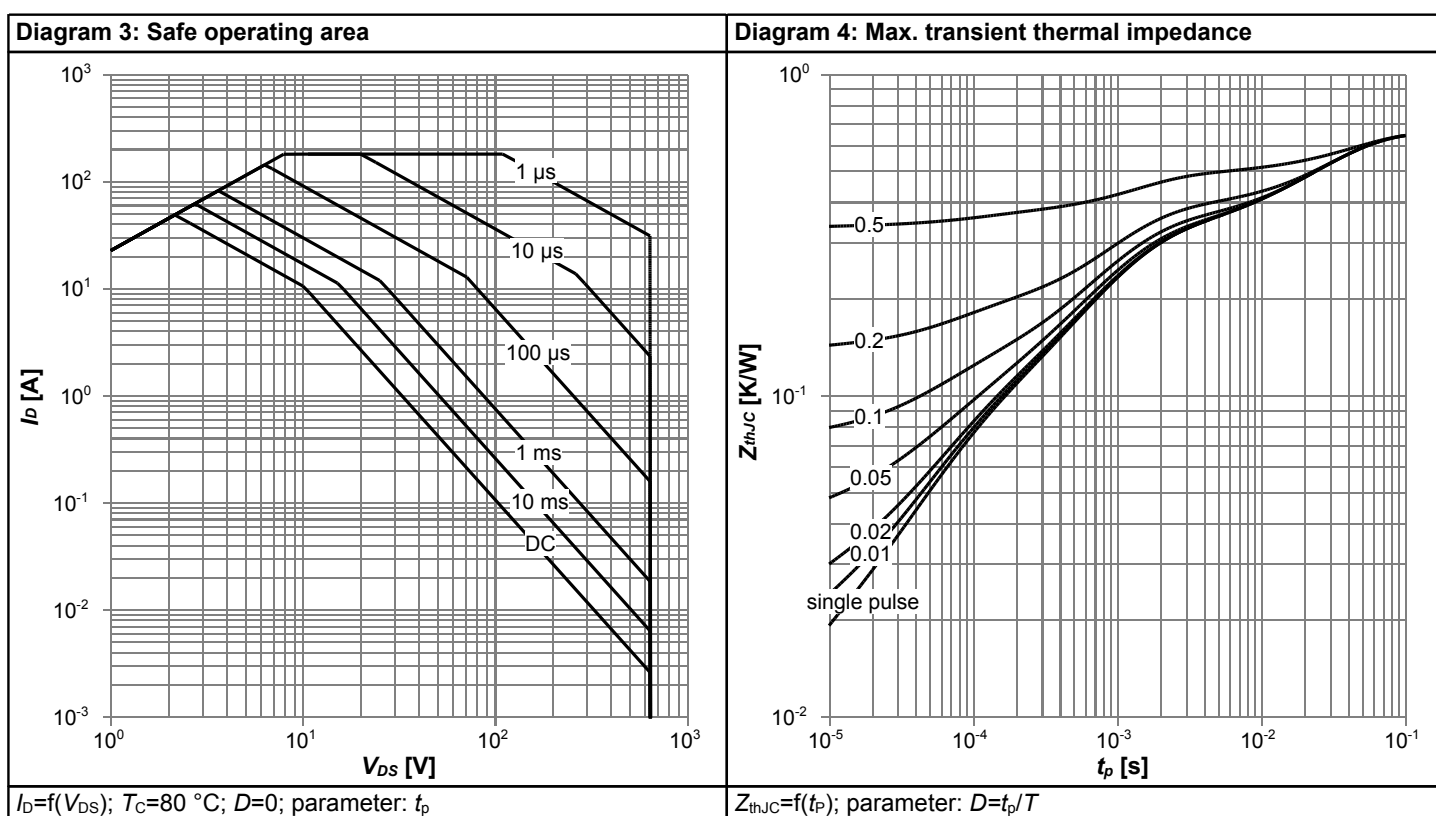
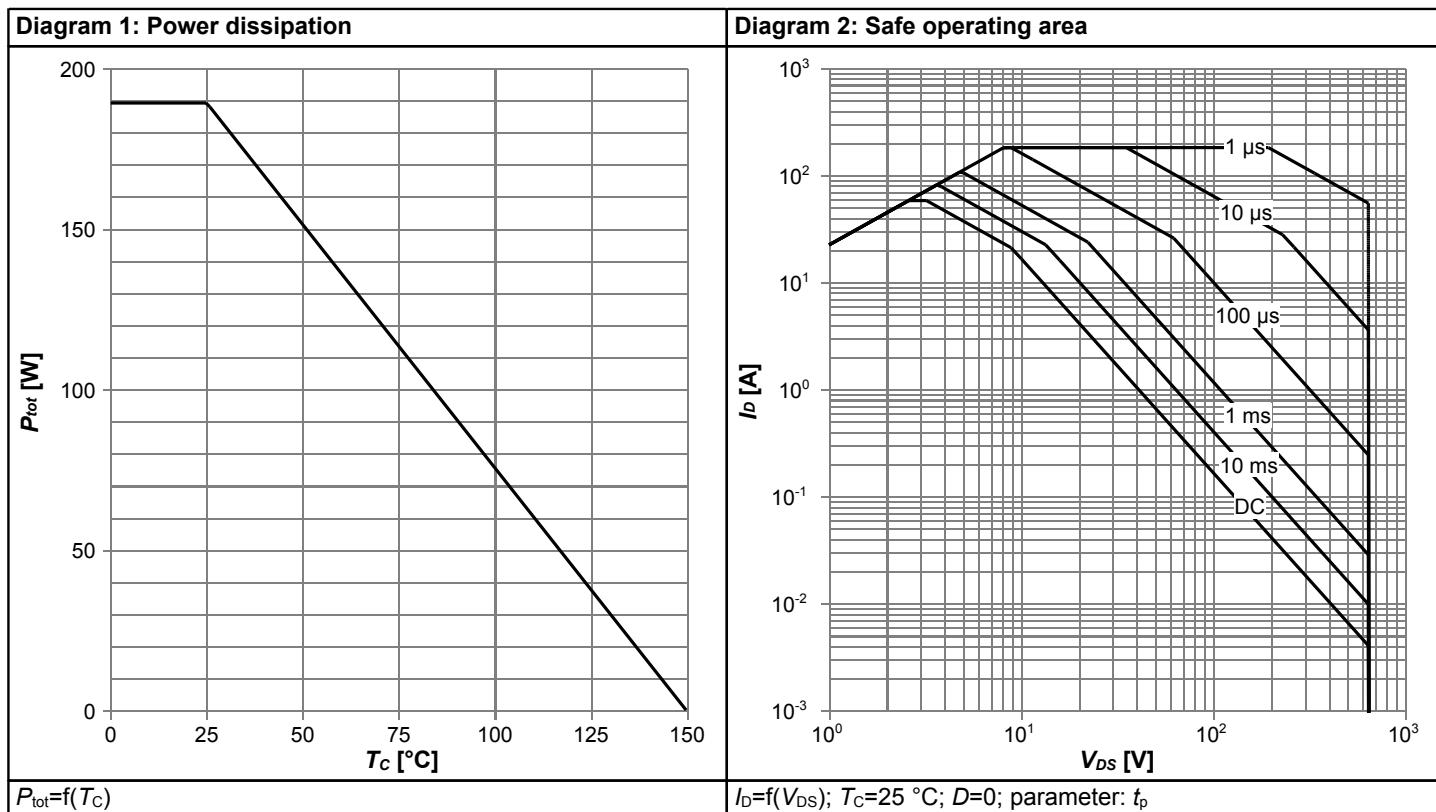
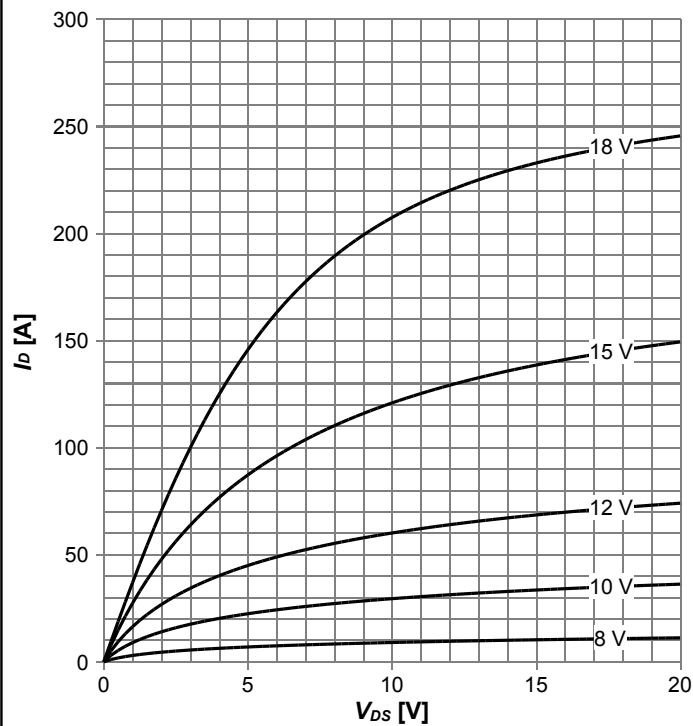
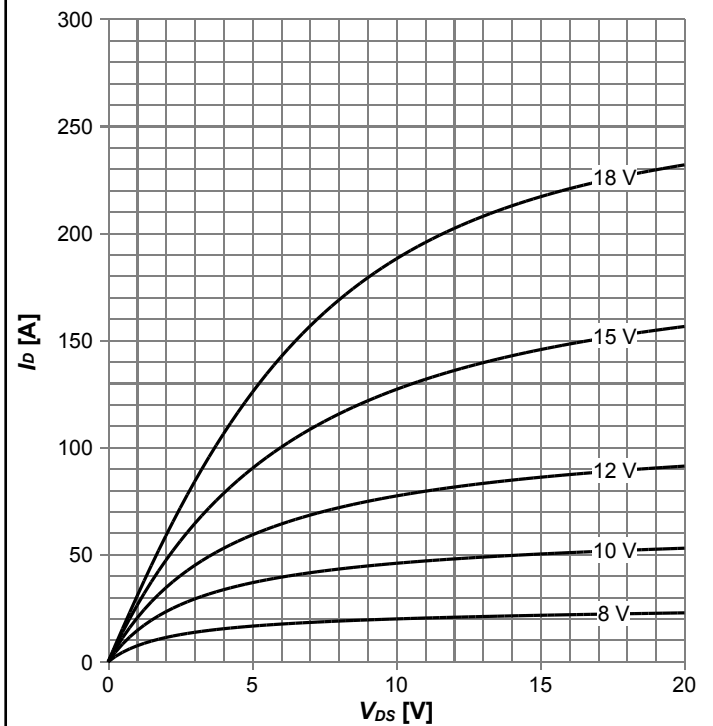


Diagram 5: Typ. output characteristics



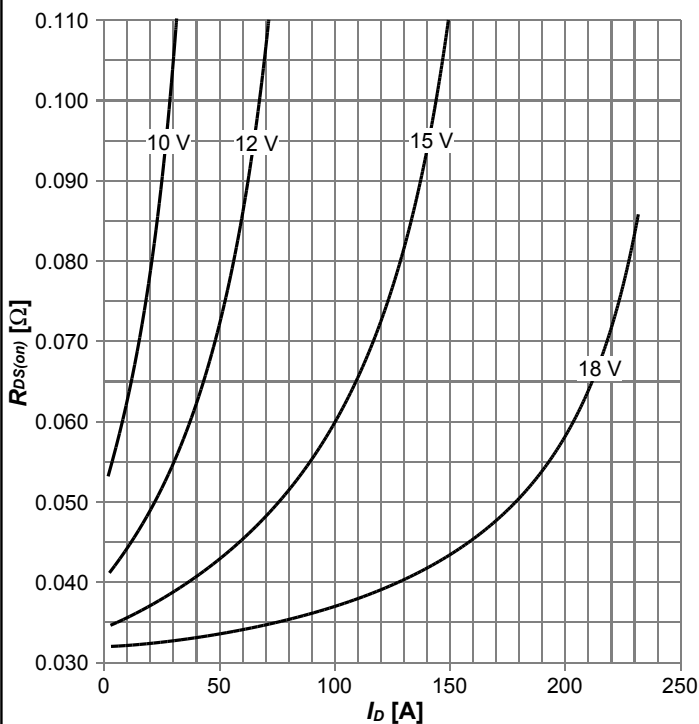
$I_D = f(V_{DS})$ ;  $T_j = 25\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. output characteristics



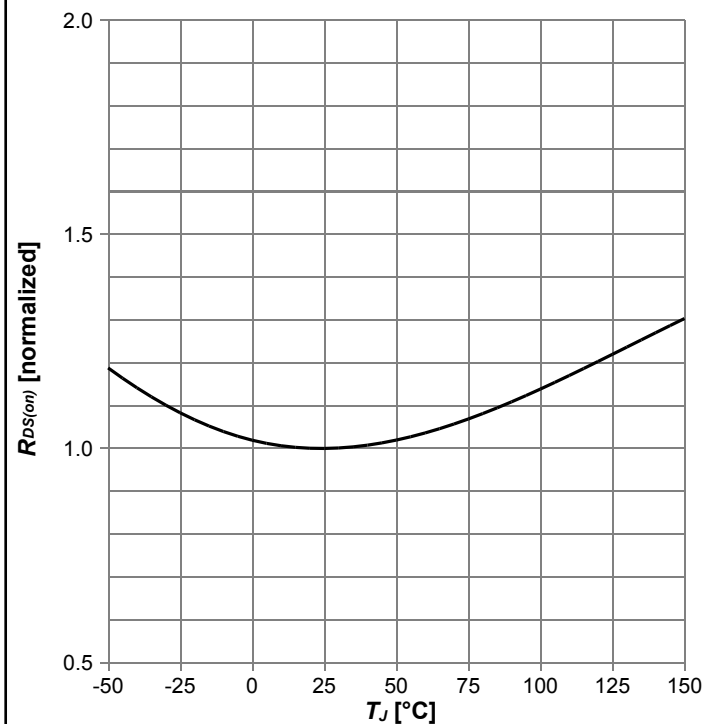
$I_D = f(V_{DS})$ ;  $T_j = 125\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. drain-source on-state resistance



$R_{DS(on)} = f(I_D)$ ;  $T_j = 125\text{ °C}$ ; parameter:  $V_{GS}$

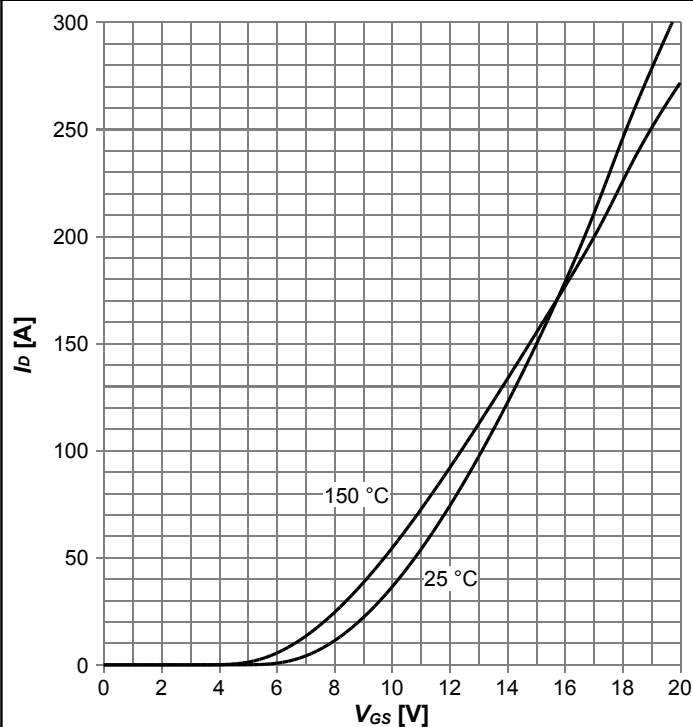
Diagram 8: Drain-source on-state resistance



$R_{DS(on)} = f(T_j)$ ;  $I_D = 38.3\text{ A}$ ;  $V_{GS} = 18\text{ V}$

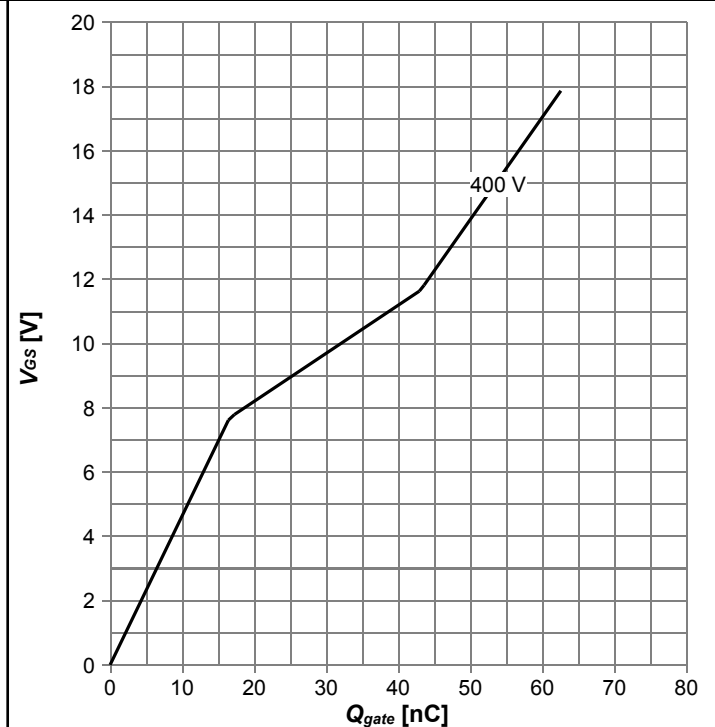


Diagram 9: Typ. transfer characteristics



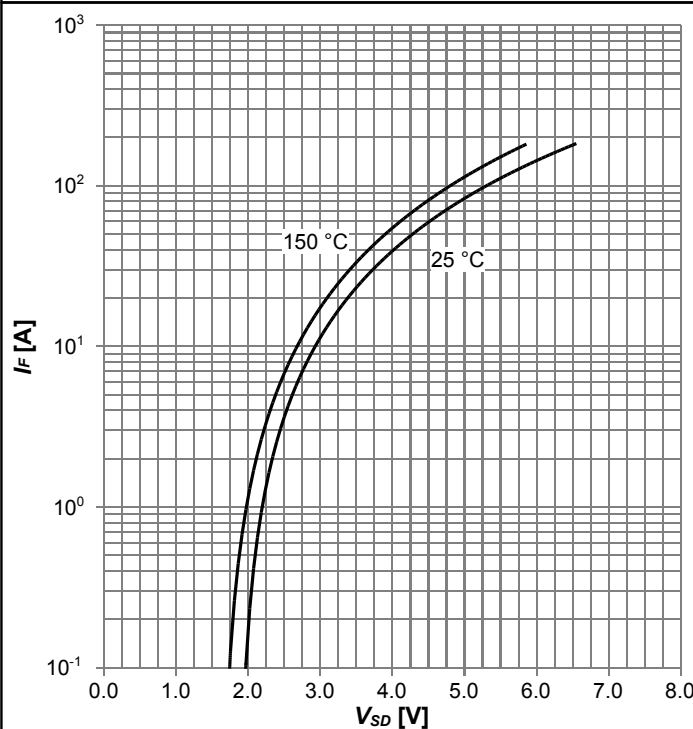
$I_D = f(V_{GS})$ ;  $V_{DS} = 20V$ ; parameter:  $T_j$

Diagram 10: Typ. gate charge



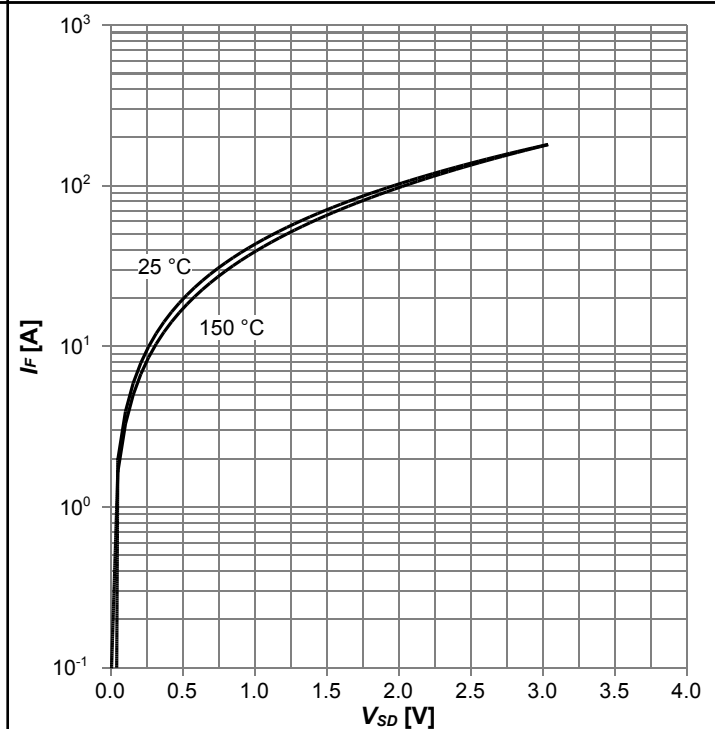
$V_{GS} = f(Q_{gate})$ ;  $I_D = 38.3$  A pulsed; parameter:  $V_{DD}$

Diagram 11: Forward characteristics of reverse diode



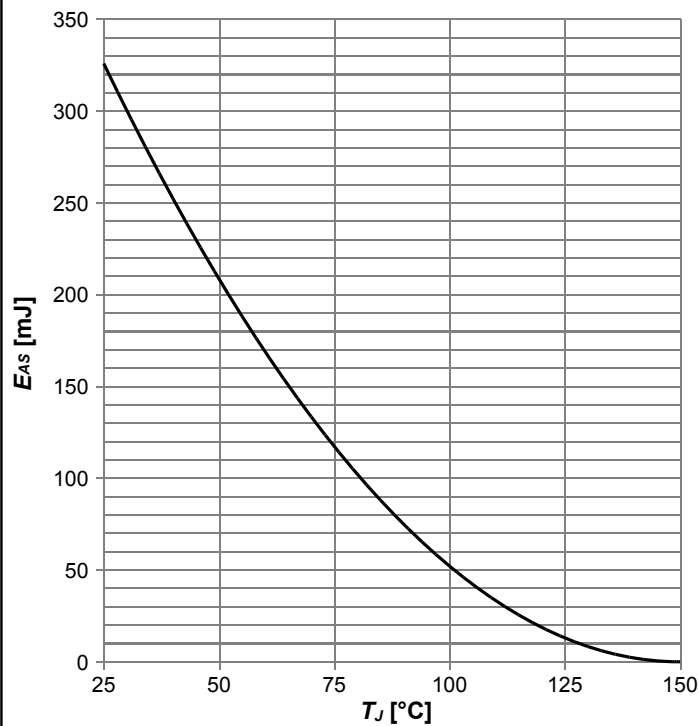
$I_F = f(V_{SD})$ ; parameter:  $T_j$

Diagram 12: Forward characteristics of reverse diode



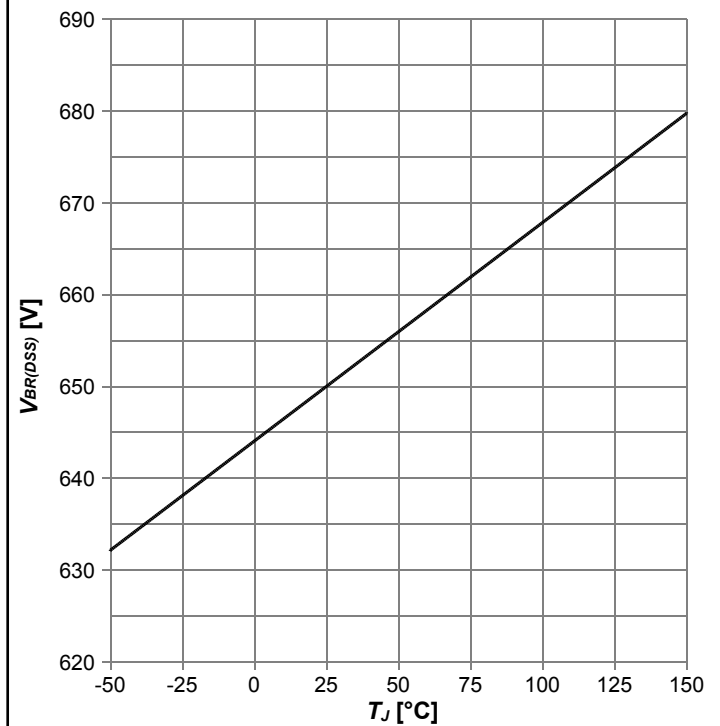
$I_F = f(V_{SD})$ ;  $V_{GS} = 18$  V; parameter:  $T_j$

Diagram 13: Avalanche energy



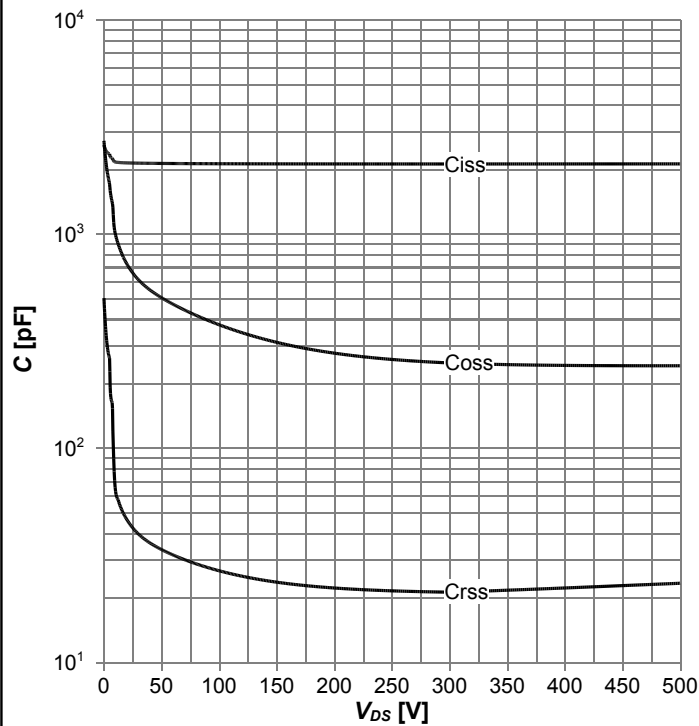
$E_{AS}=f(T_J)$ ;  $I_D=12.2$  A;  $V_{DD}=50$  V

Diagram 14: Drain-source breakdown voltage



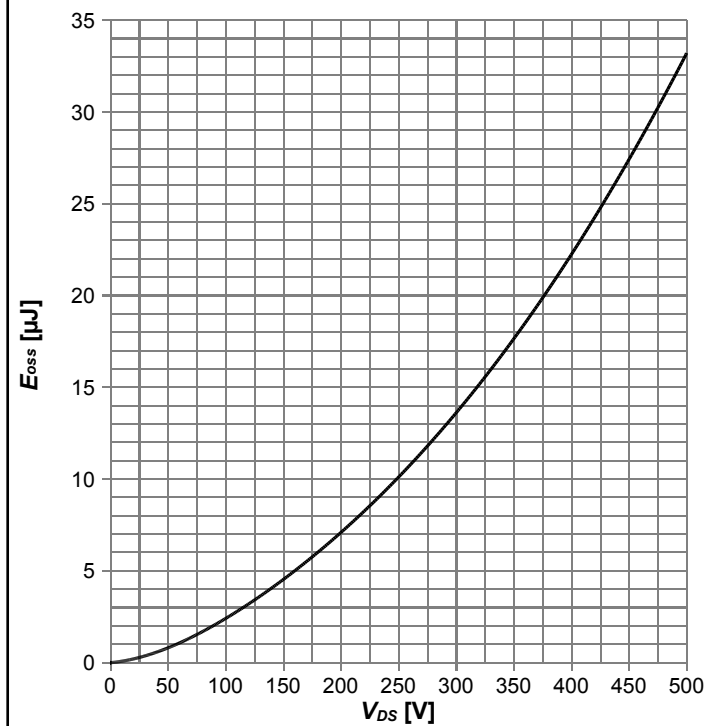
$V_{BR(DSS)}=f(T_J)$ ;  $I_D=1.1$  mA

Diagram 15: Typ. capacitances

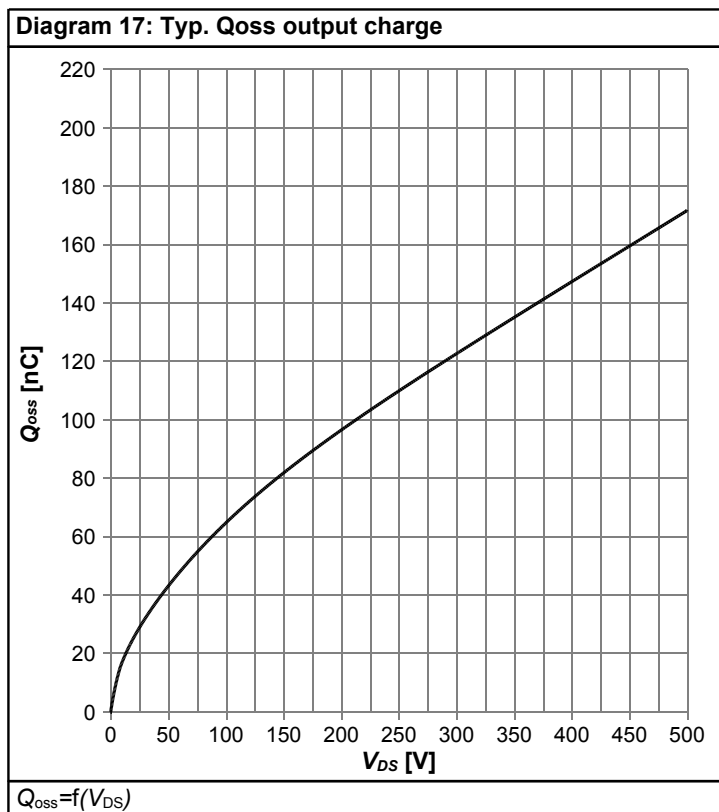


$C=f(V_{DS})$ ;  $V_{GS}=0$  V;  $f=250$  kHz

Diagram 16: Typ. Coss stored energy

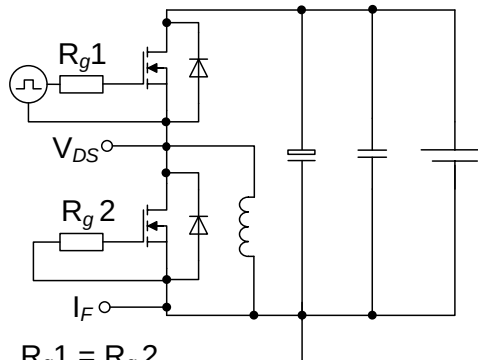
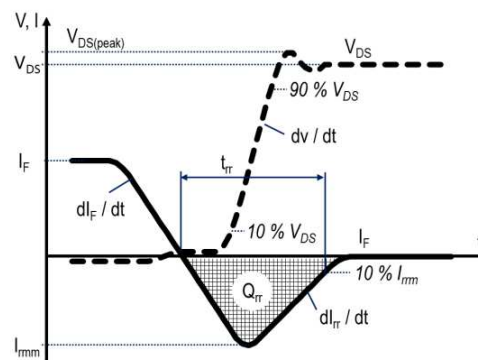


$E_{oss}=f(V_{DS})$

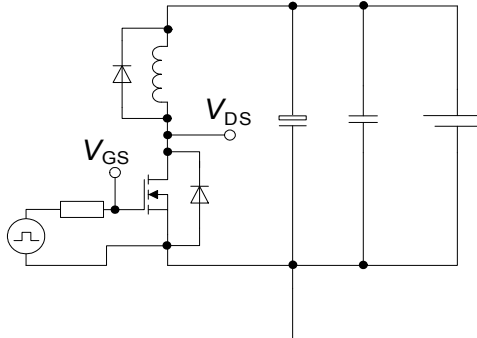
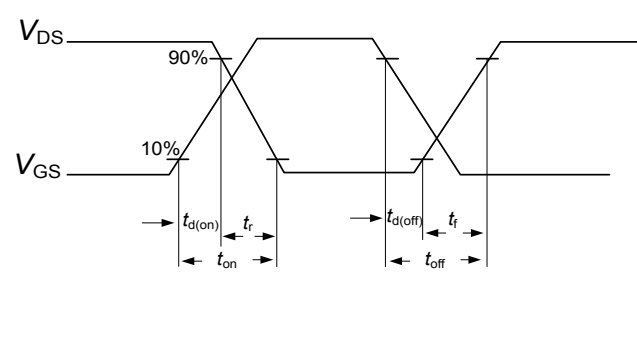


## 5 Test Circuits

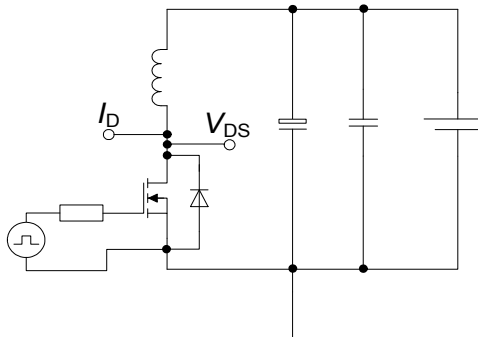
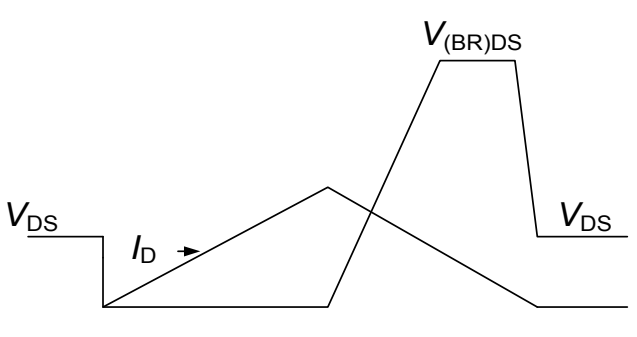
**Table 8 Diode characteristics**

| Test circuit for diode characteristics                                                                                | Diode recovery waveform                                                            |
|-----------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------|
|  <p><math>R_{g1} = R_{g2}</math></p> |  |

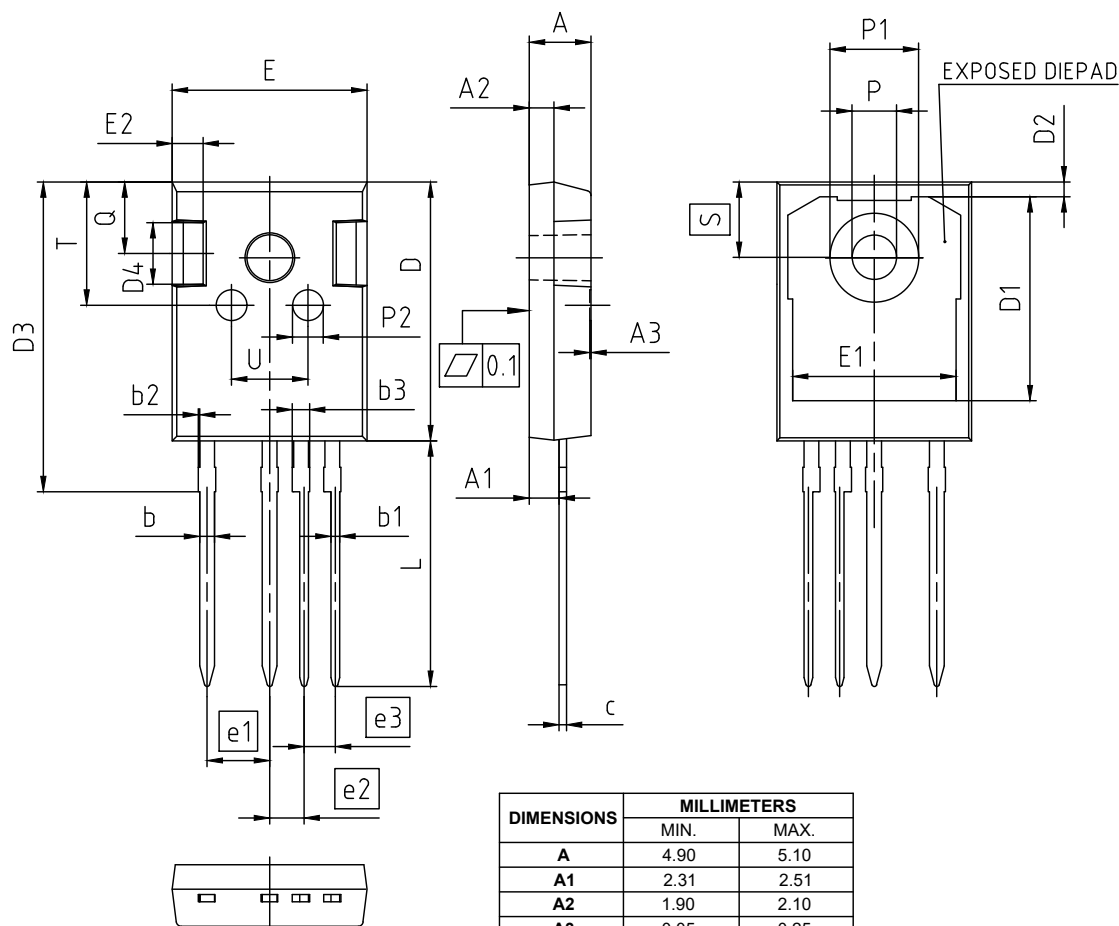
**Table 9 Switching times (ss)**

| Switching times test circuit for inductive load                                    | Switching times waveform                                                            |
|------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|
|  |  |

**Table 10 Unclamped inductive load (ss)**

| Unclamped inductive load test circuit                                               | Unclamped inductive waveform                                                         |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |

## 6 Package Outlines



NOTES:  
ALL DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.

| DIMENSIONS | MILLIMETERS |       |
|------------|-------------|-------|
|            | MIN.        | MAX.  |
| A          | 4.90        | 5.10  |
| A1         | 2.31        | 2.51  |
| A2         | 1.90        | 2.10  |
| A3         | 0.05        | 0.25  |
| b          | 1.10        | 1.30  |
| b1         | 0.65        | 0.79  |
| b2         | -           | 0.20  |
| b3         | 1.34        | 1.44  |
| c          | 0.58        | 0.66  |
| D          | 20.90       | 21.10 |
| D1         | 16.25       | 16.85 |
| D2         | 1.05        | 1.35  |
| D3         | 24.97       | 25.27 |
| D4         | 4.90        | 5.10  |
| E          | 15.70       | 15.90 |
| E1         | 13.10       | 13.50 |
| E2         | 2.40        | 2.60  |
| e1         | 5.08        |       |
| e2         | 2.79        |       |
| e3         | 2.54        |       |
| L          | 19.80       | 20.10 |
| L1         | -           | 4.30  |
| P          | 3.50        | 3.70  |
| øP1        | 7.00        | 7.40  |
| øP2        | 2.40        | 2.60  |
| Q          | 5.60        | 6.00  |
| S          | 6.15        |       |
| T          | 9.80        | 10.20 |
| U          | 6.00        | 6.40  |

|                             |
|-----------------------------|
| DOCUMENT NO.<br>Z8B00184785 |
| REVISION<br>03              |
| SCALE 2:1<br>0 5 10mm       |
| EUROPEAN PROJECTION         |
| ISSUE DATE<br>21.08.2017    |

Figure 1 Outline PG-TO 247-4-3, dimensions in mm

## **7 Appendix A**

**Table 11 Related Links**

- IFX CoolSiC M1 Webpage: [www.infineon.com](http://www.infineon.com)
- IFX CoolSiC M1 application note: [www.infineon.com](http://www.infineon.com)
- IFX CoolSiC M1 simulation model: [www.infineon.com](http://www.infineon.com)
- IFX Design tools: [www.infineon.com](http://www.infineon.com)

## Revision History

IMZA65R027M1H

**Revision: 2019-12-16, Rev. 2.0**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.0      | 2019-12-16 | Release of final version                     |

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### Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.